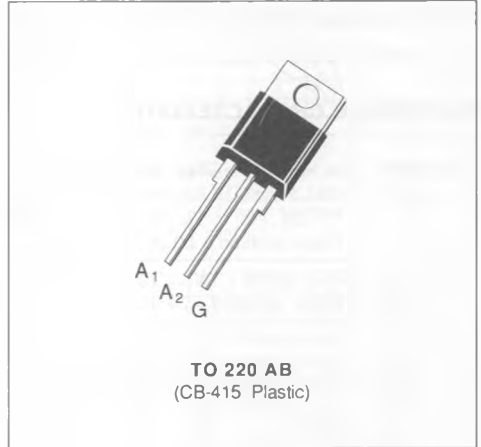




SNUBBERLESS TRIACS

- $I_{TRMS} = 10\text{ A}$ at $T_c = 100\text{ }^\circ\text{C}$.
- $V_{DRM} : 200\text{ V}$ to 800 V .
- $I_{GT} = 35\text{ mA}$ (QI-II-III).
- GLASS PASSIVATED CHIP.
- HIGH SURGE CURRENT : $I_{TSM} = 100\text{ A}$.
- HIGH COMMUTATION CAPABILITY :
(di/dt)_c > 5.5 A/ms without snubber.



DESCRIPTION

New range suited for applications such as phase control and static switching on inductive or resistive load.

ABSOLUTE RATINGS (limiting values)

| Symbol | Parameter | | Value | Unit |
|--------------------|--|-----------------------------------|----------------------------|--------------------------------------|
| I_{TRMS} | RMS on-state current (360 ° conduction angle) | $T_c = 100\text{ }^\circ\text{C}$ | 10 | A |
| I_{TSM} | Non repetitive surge peak on-state current (T_j initial = $25\text{ }^\circ\text{C}$) | $t = 8.3\text{ ms}$ | 105 | A |
| | | $t = 10\text{ ms}$ | 100 | |
| I^2t | I^2t value | $t = 10\text{ ms}$ | 50 | A^2s |
| di/dt | Critical rate of rise of on-state current (1) | Repetitive $F = 50\text{ Hz}$ | 20 | $\text{A}/\mu\text{s}$ |
| | | Non Repetitive | 100 | |
| T_{stg} T_j | Storage and operating junction temperature range | | - 40, + 150 - 40, + 125 | $^\circ\text{C}$ $^\circ\text{C}$ |

| Symbol | Parameter | BTB 10- | | | | | Unit |
|-----------|---------------------------------------|-----------|-----------|-----------|-----------|-----------|------|
| | | 200 CW | 400 CW | 600 CW | 700 CW | 800 CW | |
| V_{DRM} | Repetitive peak off-state voltage (2) | ± 200 | ± 400 | ± 600 | ± 700 | ± 800 | V |

(1) Gate supply : $I_G = 350\text{ mA}$ - $di_G/dt = 1\text{ A}/\mu\text{s}$.

(2) $T_j = 125\text{ }^\circ\text{C}$.

THERMAL RESISTANCES

| Symbol | Parameter | Value | Unit |
|-----------------|--|-------|------|
| $R_{th(j-a)}$ | Junction to ambient | 60 | °C/W |
| $R_{th(j-c)DC}$ | Junction to case for DC | 2.7 | °C/W |
| $R_{th(j-c)AC}$ | Junction to case for 360° conduction angle (F = 50 Hz) | 2 | °C/W |

GATE CHARACTERISTICS (maximum values)

$P_{GM} = 40\text{ W}$ ($t = 10\ \mu\text{s}$) $P_{G(AV)} = 1\text{ W}$ $I_{GM} = 4\text{ A}$ ($t = 10\ \mu\text{s}$) $V_{GM} = 16\text{ V}$ ($t = 10\ \mu\text{s}$).

ELECTRICAL CHARACTERISTICS

| Symbol | Test Conditions | | Quadrants | Min. | Typ. | Max. | Unit |
|---------------|--|---|-----------------------------------|------|------|------|------------------|
| I_{GT} | $T_j = 25\text{ °C}$ Pulse duration > 20 μs | $V_D = 12\text{ V}$ $R_L = 33\ \Omega$ | I-II-III | 1 | | 35 | mA |
| V_{GT} | $T_j = 25\text{ °C}$ Pulse duration > 20 μs | $V_D = 12\text{ V}$ $R_L = 33\ \Omega$ | I-II-III | | | 1.5 | V |
| V_{GD} | $T_j = 125\text{ °C}$ Pulse duration > 20 μs | $V_D = V_{DRM}$ $R_L = 3.3\text{ k}\Omega$ | I-II-III | 0.2 | | | V |
| I_H^* | $T_j = 25\text{ °C}$ Gate open | $I_T = 100\text{ mA}$ $R_L = 140\ \Omega$ | | | | 35 | mA |
| I_L | $T_j = 25\text{ °C}$ Pulse duration > 20 μs | $V_D = 12\text{ V}$ $I_G = 350\text{ mA}$ | I-III | | | 50 | mA |
| | | | II | | | 80 | |
| V_{TM}^* | $T_j = 25\text{ °C}$ | $I_{TM} = 14\text{ A}$ $t_p = 10\text{ ms}$ | | | | 1.65 | V |
| I_{DRM}^* | $T_j = 25\text{ °C}$ | V_{DRM} rated Gate open | | | | 0.01 | mA |
| | $T_j = 125\text{ °C}$ | | | | | 2 | |
| dv/dt^* | $T_j = 125\text{ °C}$ Linear slope up to 0.67 V_{DRM} | Gate open | | 250 | 500 | | V/ μs |
| $(di/dt)_c^*$ | $T_j = 125\text{ °C}$ Without snubber | V_{DRM} rated | | 5.5 | 11 | | A/ms |
| t_{g1} | $T_j = 25\text{ °C}$ $I_T = 14\text{ A}$ | $di_G/dt = 1\text{ A}/\mu\text{s}$ $V_D = V_{DRM}$ | $I_G = 350\text{ mA}$ I-II-III | | 2 | | μs |

* For either polarity of electrode A₂ voltage with reference to electrode A₁.

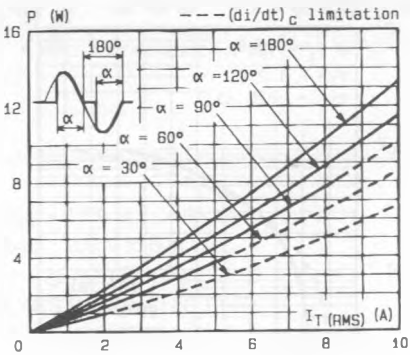


Fig. 1 - Maximum mean power dissipation versus RMS on-state current ($f = 60$ Hz).

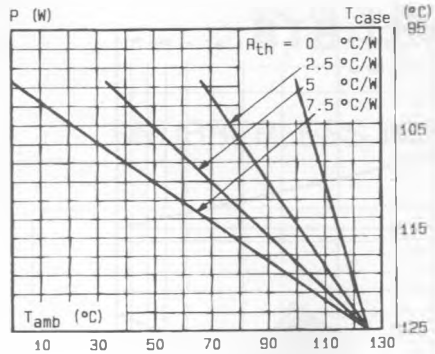


Fig. 2 - Correlation between maximum mean power dissipation and maximum allowable temperatures (T_{amb} and T_{case}) for different thermal resistances heatsink + contact.

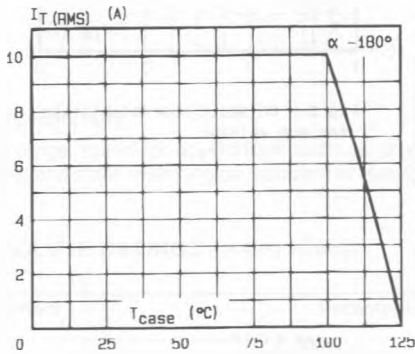


Fig. 3 - RMS on-state current versus case temperature.

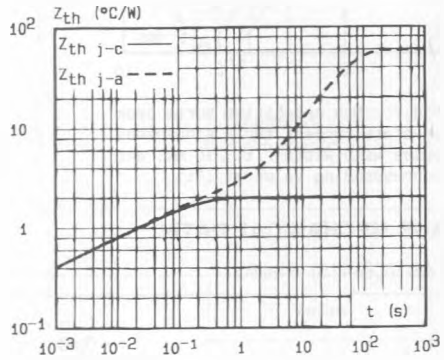


Fig. 4 - Thermal transient impedance junction to case and junction to ambient versus pulse duration.

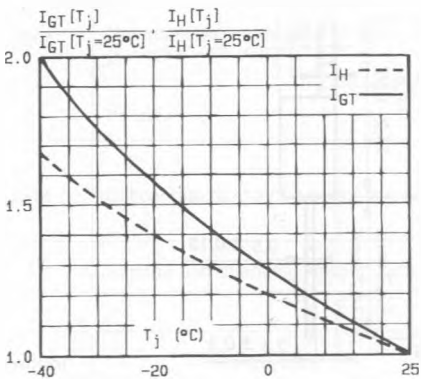


Fig. 5 - Relative variation of gate trigger current and holding current versus junction temperature.

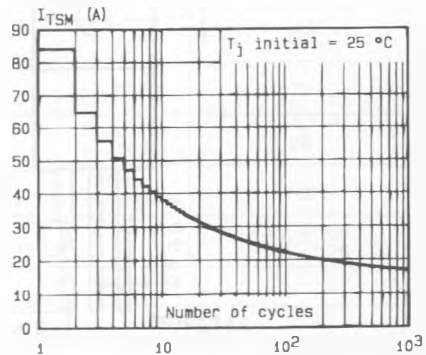


Fig. 6 - Non repetitive surge peak on-state current versus number of cycles.

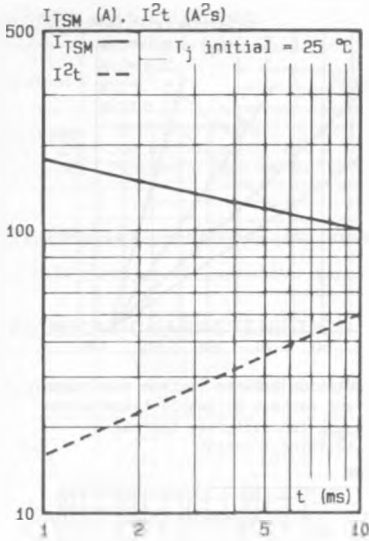


Fig.7 - Non repetitive surge peak on-state current for a sinusoidal pulse with width : $t \leq 10$ ms, and corresponding value of I^2t .

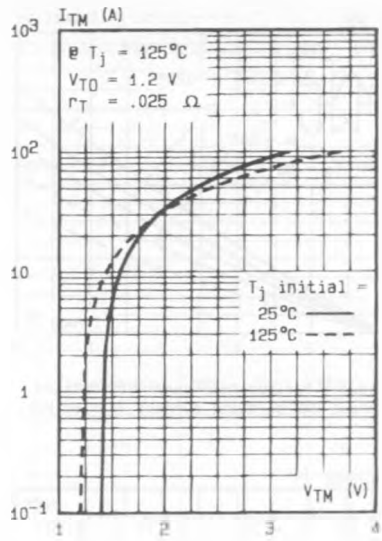
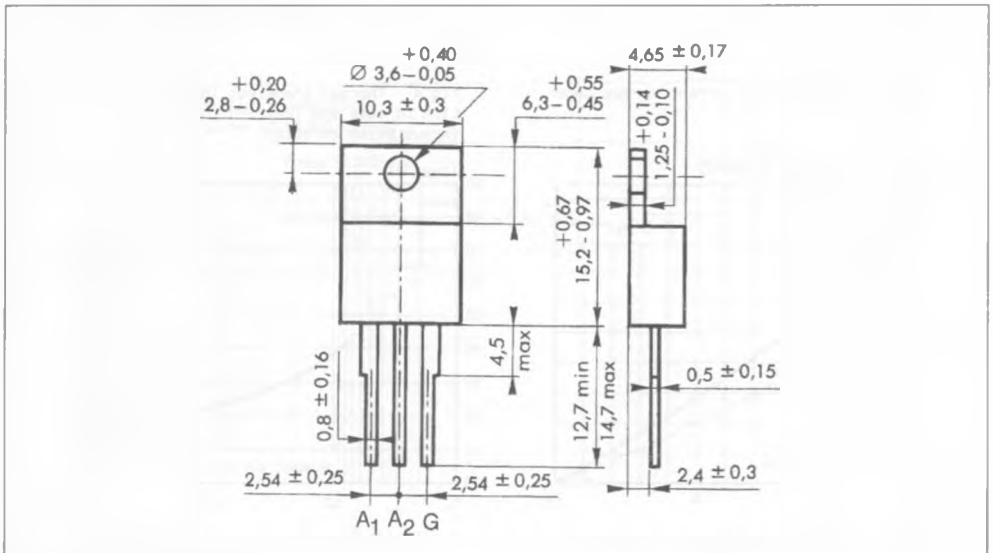


Fig.8 - On-state characteristics (maximum values).

PACKAGE MECHANICAL DATA

TO 220 AB (CB-415) Plastic



Cooling method : by conduction (method C)
 Marking : type number
 Weight : 2 g